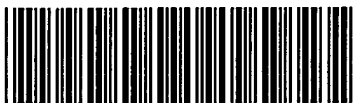


**Search Notes**

Application No.

10/042,907

Examiner

Tan V Mai

Applicant(s)

WALSTER ET AL.

Art Unit

2124

**SEARCHED**

Class	Subclass	Date	Examiner
708	446	11/17/2004	<i>Man</i>

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Double Patenting Check Data Bases Search (see attached copy)	11/17/2004	<i>Man</i>